# **NX3DV221**

# High-speed USB 2.0 switch with enable

Rev. 4 — 19 June 2013

**Product data sheet** 

# 1. General description

The NX3DV221 is a high-bandwidth switch designed for the switching of high-speed USB 2.0 signals in handset and consumer applications. These applications could be cell phones, digital cameras, and notebooks with hubs or controllers with limited USB I/Os. The wide bandwidth (1 GHz) of this switch allows signal to pass with minimum edge and phase distortion. The device multiplexes differential outputs from a USB host device to one of two corresponding outputs. The switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. It is designed for low bit-to-bit skew and high channel-to-channel noise isolation, and is compatible with various standards, such as high-speed USB 2.0 (480 Mbps).

### 2. Features and benefits

- Wide supply voltage range from 2.3 V to 3.6 V
- Switch voltage accepts signals up to 5.5 V
- 1.8 V control logic at V<sub>CC</sub> = 3.6 V
- Low-power mode when OE is HIGH (2 μA maximum)
- 6 Ω (maximum) ON resistance
- lacksquare 0.1  $\Omega$  (typical) ON resistance mismatch between channels
- 6 pF (typical) ON-state capacitance
- High bandwidth (1.0 GHz typical)
- Latch-up performance exceeds 100 mA per JESD 78B Class II Level A
- ESD protection:
  - ◆ HBM JESD22-A114F Class 3A exceeds 8000 V
  - ◆ CDM JESD22-C101E exceeds 1000 V
  - ◆ HBM exceeds 12000 V for I/O to GND protection
- Specified from -40 °C to +85 °C

# 3. Applications

Routes signals for USB 1.0, 1.1 and 2.0



# High-speed USB 2.0 switch with enable

# 4. Ordering information

Table 1. Ordering information

Type number	Package							
	Temperature range	Name	Description	Version				
NX3DV221GM	–40 °C to +85 °C	XQFN10	plastic extremely thin quad flat package; no leads; 10 terminals; body 2 $\times$ 1.55 $\times$ 0.5 mm	SOT1049-3				
NX3DV221TK	–40 °C to +85 °C	HVSON10	plastic thermal enhanced very thin small outline package; no leads; 10 terminals; $3\times3\times0.85$ mm	SOT650-2				

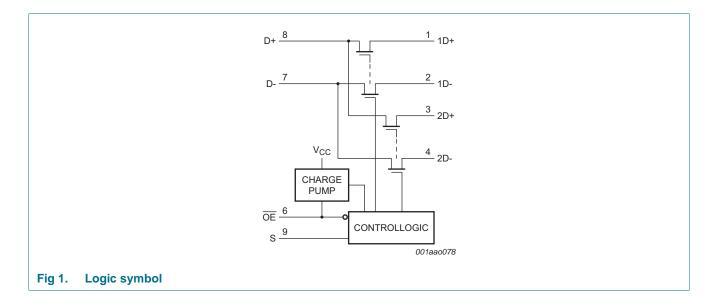
# 5. Marking

Table 2. Marking

Type number	Marking code <sup>[1]</sup>
NX3DV221GM	x21
NX3DV221TK	x21

<sup>[1]</sup> The pin 1 indicator is located on the lower left corner of the device, below the marking code.

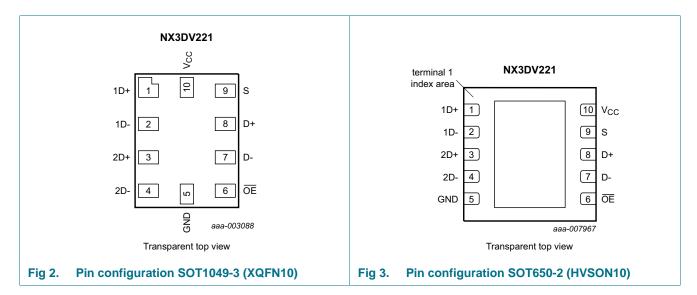
# 6. Functional diagram



High-speed USB 2.0 switch with enable

# 7. Pinning information

### 7.1 Pinning



# 7.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
1D+	1	independent input or output
1D-	2	independent input or output
2D+	3	independent input or output
2D-	4	independent input or output
GND	5	ground (0 V)
ŌE	6	output enable input (active LOW)
D-	7	common input or output
D+	8	common input or output
S	9	select input
V <sub>CC</sub>	10	supply voltage

# 8. Functional description

Table 4. Function table[1]

Input		Channel
S	OE	
L	L	D+ = 1D+; D- = 1D-
Н	L	D+ = 2D+; D- = 2D-
X	Н	switches off

<sup>[1]</sup> H = HIGH voltage level; L = LOW voltage level; X = don't care.

NX3DV221

### High-speed USB 2.0 switch with enable

# 9. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+4.6	V
VI	input voltage	S, OE input	<u>[1]</u> –0.5	+7.0	V
V <sub>SW</sub>	switch voltage		<u>[2]</u> –0.5	+7.0	V
I <sub>IK</sub>	input clamping current	$V_1 < -0.5 V$	<b>–50</b>	-	mA
I <sub>SK</sub>	switch clamping current	$V_1 < -0.5 V$	<b>–50</b>	-	mA
I <sub>SW</sub>	switch current		-	±120	mA
I <sub>CC</sub>	supply current		-	+100	mA
$I_{GND}$	ground current		-100	-	mA
T <sub>stg</sub>	storage temperature		<b>–65</b>	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$	-	250	mW

<sup>[1]</sup> The minimum input voltage rating may be exceeded if the input current rating is observed.

# 10. Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		2.3	3.6	V
VI	input voltage	S, OE input	0	$V_{CC}$	V
$V_{SW}$	switch voltage		0	5.5	V
T <sub>amb</sub>	ambient temperature		-40	+85	°C

# 11. Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	rameter Conditions		T <sub>amb</sub> = 25 °C			T <sub>amb</sub> =-40 °C to +85 °C		
			Min	Тур	Max	Min	Max		
$V_{IH}$	HIGH-level	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	-	-	0.46V <sub>CC</sub>	-	V	
	input voltage	$V_{CC}$ = 2.7 V to 3.6 V	-	-	-	$0.46V_{CC}$	-	V	
$V_{IL}$	V <sub>IL</sub> LOW-level	$V_{CC}$ = 2.3 V to 2.7 V	-	-	-	-	$0.25V_{CC}$	V	
	input voltage	$V_{CC}$ = 2.7 V to 3.6 V	-	-	-	-	$0.25V_{CC}$	V	
$V_{IK}$	input clamping voltage	$V_{CC} = 2.7 \text{ V}, 3.6 \text{ V};$ $I_I = -18 \text{ mA}$	-	-	-	-	-1.8	V	
I <sub>I</sub>	input leakage current	S, $\overline{OE}$ input; $V_{CC} = 0 \text{ V}, 2.7 \text{ V}, 3.6;$ $V_{I} = \text{GND to } 3.6 \text{ V}$	-	0.01	-	-	±1	μΑ	

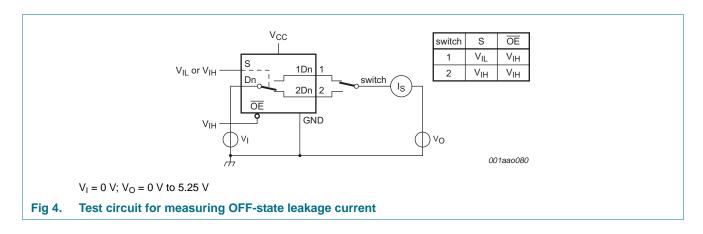
<sup>[2]</sup> The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed.

# High-speed USB 2.0 switch with enable

**Table 7. Static characteristics** ...continued
At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	Ta	<sub>amb</sub> = 25	°C	T <sub>amb</sub> =-40 °	°C to +85 °C	Unit
			Min	Тур	Max	Min	Max	
I <sub>OFF</sub>	power-off	per pin; V <sub>CC</sub> = 0 V	'	'		•	'	
	leakage current	$V_{SW} = 0 V \text{ to } 2.7 V$	-	0.01	-	-	±2.0	μΑ
		$V_{SW} = 0 \text{ V to } 3.6 \text{ V}$	-	0.01	-	-	±2.0	μΑ
		$V_{SW} = 0 \text{ V to } 5.25 \text{ V}$	-	0.01	-	-	±3.0	μΑ
I <sub>S(OFF)</sub>	OFF-state leakage current	nD+ and nD- ports; see Figure 4						
		$V_{CC} = 2.7 \text{ V}, 3.6 \text{ V}$	-	-	-	-	±1	μΑ
$I_{CC}$	supply current	$V_{CC} = 2.7 \text{ V}, 3.6 \text{ V}$						
		OE = GND	-	18.5	-	-	30	μΑ
		$\overline{OE} = V_{CC}$ (low-power mode)	-	0.01	-	-	2	μΑ
$\Delta I_{CC}$	additional supply current	S, $\overline{\text{OE}}$ input; one input at 1.8 V; other inputs at GND or V <sub>CC</sub>						
		V <sub>CC</sub> = 2.7 V	-	0.8	-	-	1.8	μΑ
		V <sub>CC</sub> = 3.6 V	-	12.5	-	-	20	μΑ
Cı	input capacitance	$V_{SW}$ = GND or $V_{CC}$ ; $V_{CC}$ = 2.5 V, 3.3 V	-	1	-	-	2.5	pF
C <sub>S(OFF)</sub>	OFF-state capacitance	$V_{SW}$ = GND or $V_{CC}$ ; $V_{CC}$ = 2.5 V, 3.3 V	-	3	-	-	5.0	pF
C <sub>S(ON)</sub>	ON-state capacitance	$V_{SW}$ = GND or $V_{CC}$ ; $V_{CC}$ = 2.5 V, 3.3 V	-	6	-	-	7.5	pF

### 11.1 Test circuits



### High-speed USB 2.0 switch with enable

### 11.2 ON resistance

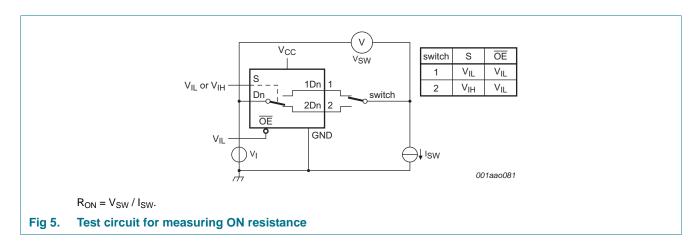
Table 8. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for graphs see Figure 6.

Symbol	Parameter	Conditions		T <sub>amb</sub> =	-40 °C to	+85 °C	$T_{amb} = -40^{\circ}$	°C to +85 °C	Unit
				Min	Typ[1]	Max	Min	Max	
R <sub>ON</sub>	ON resistance	$V_{CC} = 2.3 \text{ V}, 3.0 \text{ V}$ see Figure 5							
		$V_{I} = 0 V;$ $I_{I} = 30 \text{ mA}$		-	3.6	-	-	6	Ω
		$V_I = 2.4 \text{ V};$ $I_I = -15 \text{ mA}$		-	4.3	-	-	7	Ω
$\Delta R_{ON}$	ON resistance mismatch between channels	$V_{CC} = 2.3 \text{ V}, 3.0 \text{ V}$	[2]						
		$V_{I} = 0 V;$ $I_{I} = 30 \text{ mA}$		-	0.1	-	-	-	Ω
		$V_I = 1.7 \text{ V};$ $I_I = -15 \text{ mA}$		-	0.1	-	-	-	Ω
$R_{ON(flat)}$	ON resistance (flatness)	$V_{CC} = 2.3 \text{ V}, 3.0 \text{ V};$ $V_{I} = 0 \text{ V to } V_{CC}$	[3]						
		$I_I = 30 \text{ mA}$		-	0.8	-	-	-	Ω
		$I_I = -15 \text{ mA}$		-	0.7	-	-	-	Ω

<sup>[1]</sup> Typical values are measured at  $T_{amb}$  = 25 °C.

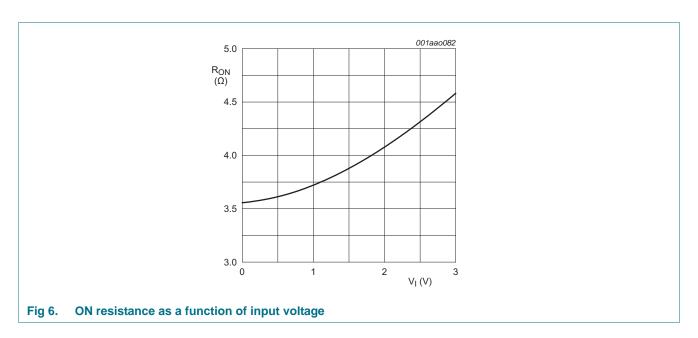
### 11.3 ON resistance test circuit and waveforms



<sup>[2]</sup> Measured at identical V<sub>CC</sub>, temperature and input voltage.

<sup>[3]</sup> Flatness is defined as the difference between the maximum and minimum value of ON resistance measured at identical V<sub>CC</sub> and temperature.

# High-speed USB 2.0 switch with enable



# 12. Dynamic characteristics

Table 9. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit, see Figure 10.

Symbol	Parameter	Conditions		Ta	<sub>amb</sub> = 25 '	°C	$T_{amb} = -40^{\circ}$	Unit	
				Min	Typ[1]	Max	Min	Max	
t <sub>pd</sub>	propagation delay	Dn to nDn or nDn to Dn; see Figure 7	[2][3]						
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	0.25	-	-	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	0.25	-	-	-	ns
t <sub>en</sub>	enable time	S to Dn, nDn; see Figure 9	[3]						
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	-	-	-	50	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	-	-	-	30	ns
		OE to Dn, nDn; see Figure 9	[3]						
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	-	-	-	32	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	-	-	-	17	ns
t <sub>dis</sub>	disable time	S to Dn, nDn; see Figure 9	[3]						
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	-	-	-	23	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	-	-	-	12	ns
		OE to Dn, nDn; see Figure 9	[3]						
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	-	-	-	12	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	-	-	-	10	ns

### High-speed USB 2.0 switch with enable

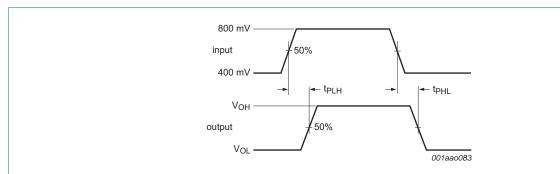
Table 9. Dynamic characteristics ... continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit, see Figure 10.

Symbol	Parameter	Conditions		T <sub>amb</sub> = 25 °C		$T_{amb} = -40^{\circ}$	Unit		
				Min	Typ[1]	Max	Min	Max	
$t_{sk(o)}$	output skew time	see Figure 8	4]						
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	0.1	-	-	0.2	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	0.1	-	-	0.2	ns
t <sub>sk(p)</sub>	pulse skew time	see Figure 7	4]						
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	0.1	-	-	0.2	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	0.1	-	-	0.2	ns

- [1] Typical values are measured at  $T_{amb}$  = 25 °C and  $V_{CC}$  = 2.5 V and 3.3 V respectively.
- [2] The propagation delay is the calculated RC time constant of the typical ON resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
- [3]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .
- [4] Guaranteed by design.

# 12.1 Waveforms, test circuit and graphs



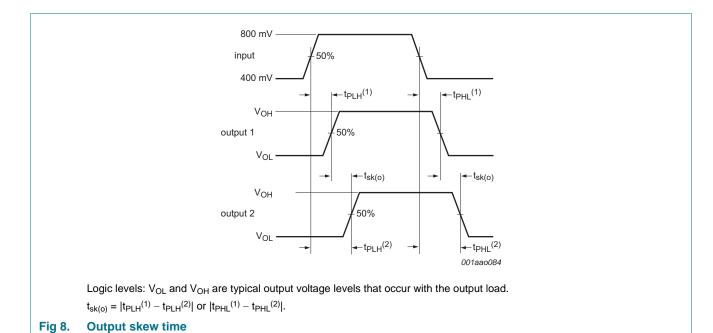
Logic levels:  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

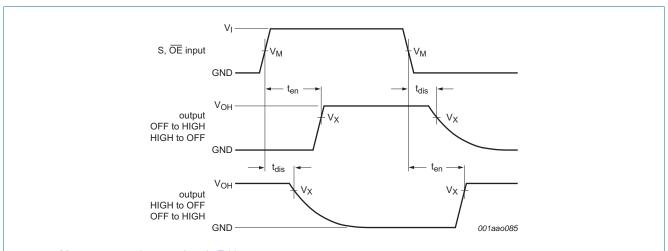
 $t_{sk(p)} = |t_{PHL} - t_{PLH}|.$ 

Fig 7. The data input to output propagation delay times and pulse skew time

8 of 19

### High-speed USB 2.0 switch with enable





Measurement points are given in Table 10.

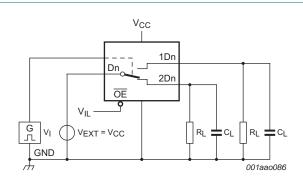
Logic levels:  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

Fig 9. Enable and disable times

Table 10. Measurement points

Supply voltage	Input	Output	
V <sub>CC</sub>	V <sub>M</sub>	V <sub>X</sub>	
2.3 V to 3.6 V	0.5V <sub>I</sub>	1. 8 V	0.9V <sub>OH</sub>

### High-speed USB 2.0 switch with enable



Test data is given in Table 11.

Definitions test circuit:

R<sub>L</sub> = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $V_{EXT}$  = External voltage for measuring switching times.

 $V_I$  may be connected to S or  $\overline{OE}$ .

### Fig 10. Test circuit for switching times

Table 11. Test data

Supply voltage	Input	Input		Load		
V <sub>CC</sub>	V <sub>I</sub>	t <sub>r</sub> , t <sub>f</sub>	CL	R <sub>L</sub>		
2.3 V to 3.6 V	1.8 V	≤ 5 ns	50 pF	500 Ω		

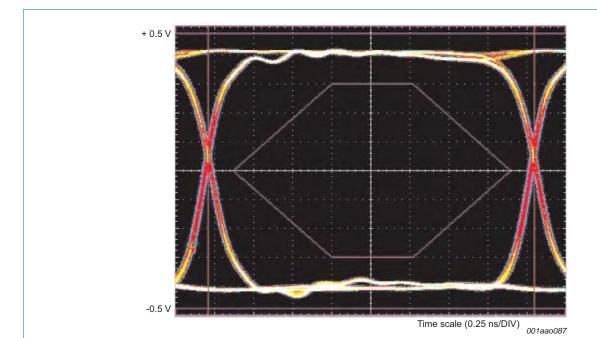
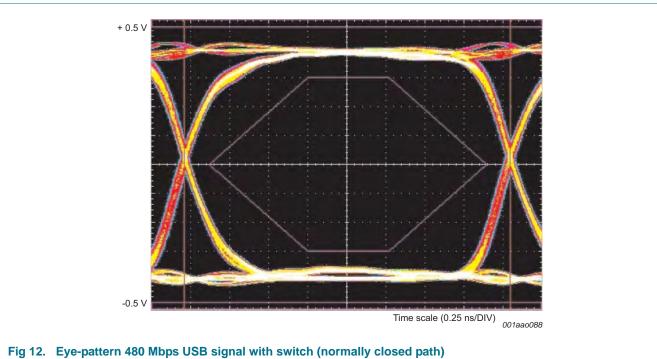


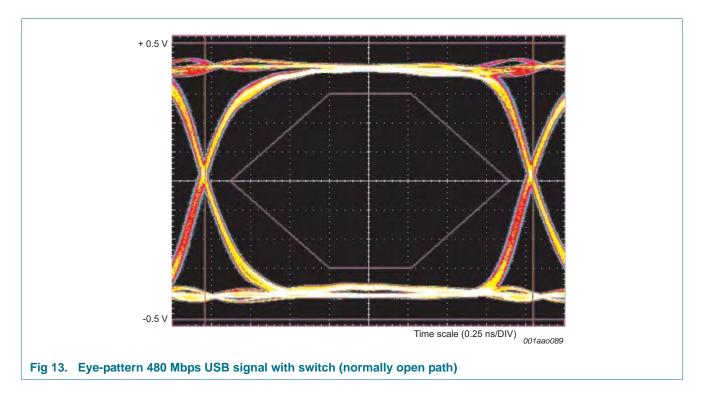
Fig 11. Eye-pattern 480 Mbps USB signal with no switch.

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### High-speed USB 2.0 switch with enable

# 12.2 Additional dynamic characteristics

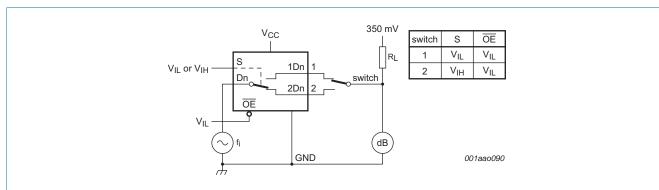
#### Table 12. Additional dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V);  $V_l = \text{GND}$  or  $V_{CC}$  (unless otherwise specified);  $t_r = t_f \le 5$  ns;  $T_{amb} = 25$  °C.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
f <sub>(-3dB)</sub> -3 dB frequency response	-3 dB frequency	$R_L = 50 \Omega$ ; see Figure 14	[1][2]				
	response	V <sub>CC</sub> = 2.3 V to 2.7 V		-	1.0	-	GHz
		V <sub>CC</sub> = 3.0 V to 3.6 V		-	1.0	-	GHz
$\alpha_{\text{iso}}$ isolation (OFF-state)	isolation (OFF-state)	$f_i$ = 250 MHz; $R_L$ = 50 $\Omega$ ; see Figure 15	[1][2]				
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	-38	-	dB
		V <sub>CC</sub> = 3.0 V to 3.6 V		-	-38	-	dB
Xtalk crosstalk		between switches; $f_i = 250 \text{ MHz}$ ; $R_L = 50 \Omega$ ; see Figure 16	[1][2]				
		V <sub>CC</sub> = 2.3 V to 2.7 V		-	-40	-	dB
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	-40	-	dB

<sup>[1]</sup> f<sub>i</sub> is biased at 350 mV.

### 12.3 Test circuits

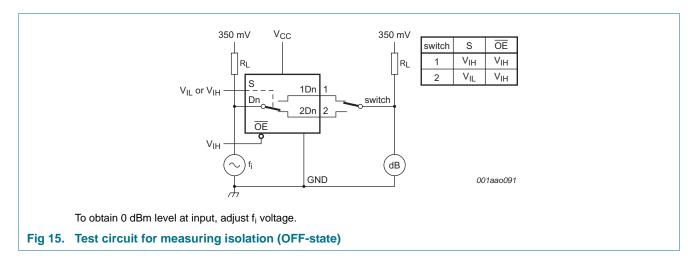


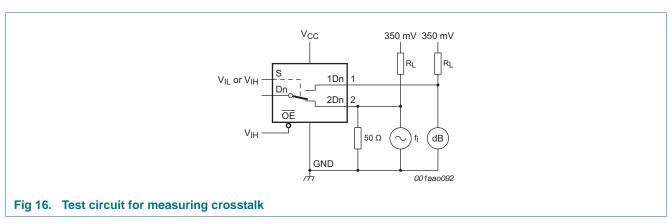
To obtain 0 dBm level at output, adjust f<sub>i</sub> voltage. Increase f<sub>i</sub> frequency until dB meter reads –3 dB.

Fig 14. Test circuit for measuring the frequency response when switch is in ON-state

<sup>[2]</sup>  $V_i = 632 \text{ mV (p-p)}$ 

# High-speed USB 2.0 switch with enable





### High-speed USB 2.0 switch with enable

# 13. Package outline

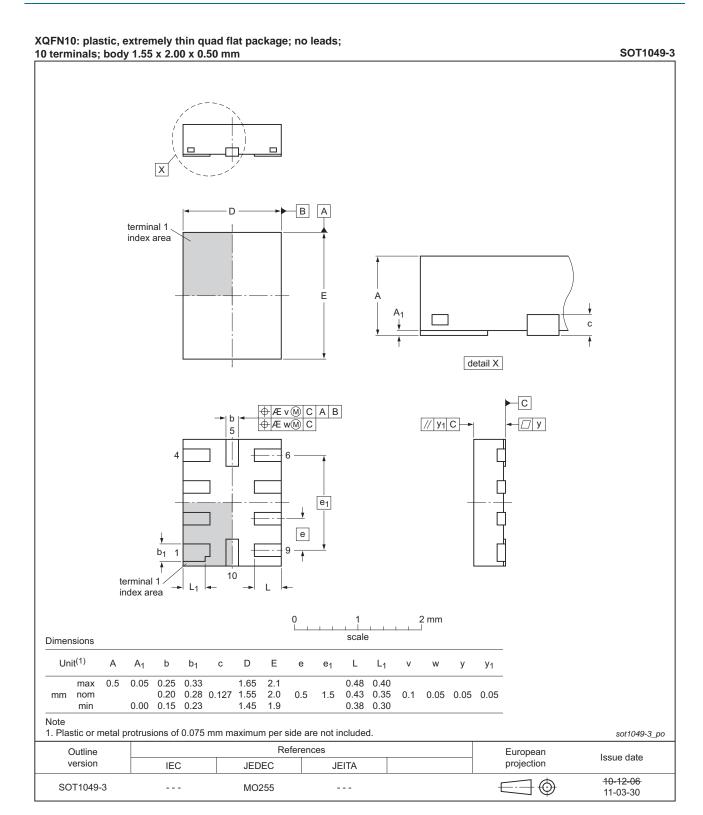


Fig 17. Package outline SOT1049-3 (XQFN10)

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### High-speed USB 2.0 switch with enable

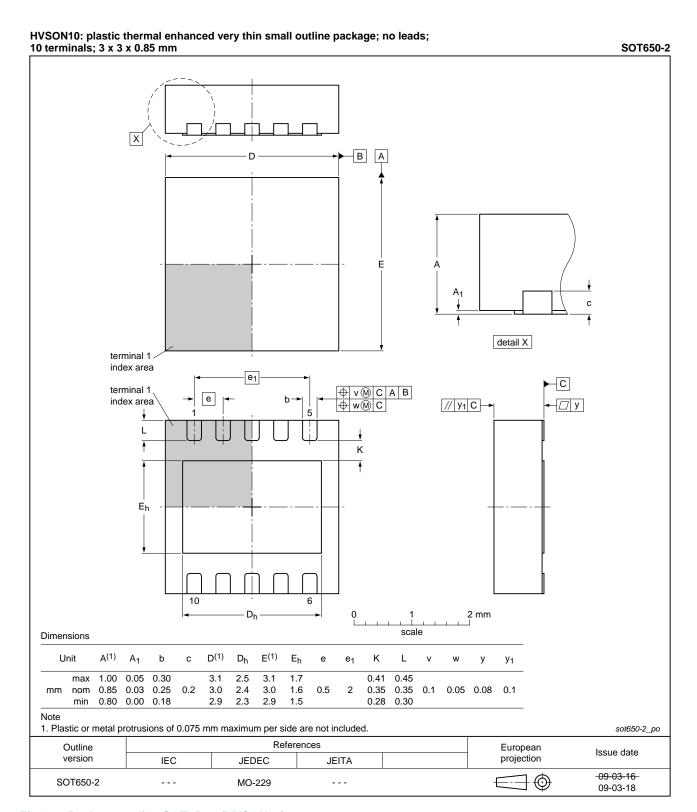


Fig 18. Package outline SOT650-2 (HVSON10)

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# High-speed USB 2.0 switch with enable

# 14. Abbreviations

#### Table 13. Abbreviations

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal Oxide Semiconductor
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model

# 15. Revision history

### Table 14. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
NX3DV221 v.4	20130619	Product data sheet	-	NX3DV221 v.3
Modifications:	<ul> <li>Type number</li> </ul>	er NX3DV221TK added.		
	<ul> <li>Package out</li> </ul>	tline drawing added ( <u>Figure 1</u>	<u>8</u> ).	
NX3DV221 v.3	20120705	Product data sheet	-	NX3DV221 v.2
NX3DV221 v.2	20111109	Product data sheet	-	NX3DV221 v.1
NX3DV221 v.1	20110421	Product data sheet	-	-

#### High-speed USB 2.0 switch with enable

# 16. Legal information

#### 16.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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# High-speed USB 2.0 switch with enable

# 18. Contents

1	General description	1
2	Features and benefits	1
3	Applications	1
4	Ordering information	
5	Marking	2
6	Functional diagram	
7	Pinning information	3
7.1	Pinning	3
7.2	Pin description	
8	Functional description	3
9	Limiting values	4
10	Recommended operating conditions	4
11	Static characteristics	4
11.1	Test circuits	5
11.2	ON resistance	_
11.3	ON resistance test circuit and waveforms	6
12	Dynamic characteristics	7
12.1	Waveforms, test circuit and graphs	
12.2	Additional dynamic characteristics	
12.3	Test circuits	12
13	Package outline	14
14	Abbreviations	16
15	Revision history	16
16	Legal information 1	17
16.1	Data sheet status	17
16.2	Definitions	17
16.3		17
16.4	Trademarks	18
17	Contact information	18
18	Contents	19

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